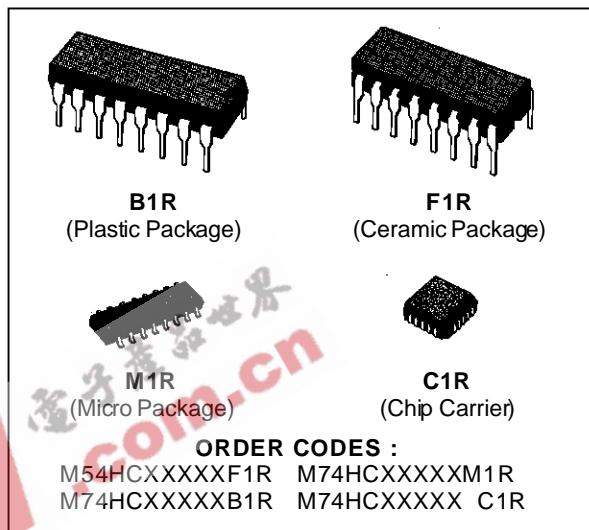


8 STAGE PRESETTABLE SYNCHRONOUS DOWN COUNTERS

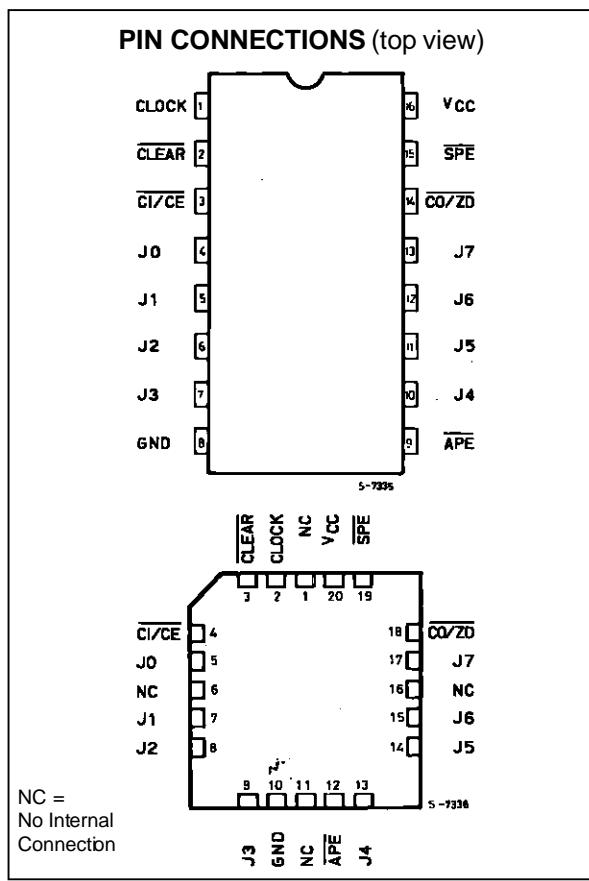
- HIGH SPEED
 $f_{MAX} = 40\text{ MHz (TYP.)}$ at $V_{CC} = 5\text{ V}$
- LOW POWER DISSIPATION
 $I_{CC} = 4\text{ }\mu\text{A (MAX.)}$ at $T_A = 25\text{ }^\circ\text{C}$
- HIGH NOISE IMMUNITY
 $V_{NIH} = V_{NIL} = 28\% V_{CC}$ (MIN.)
- OUTPUT DRIVE CAPABILITY
10 LSTTL LOADS
- SYMMETRICAL OUTPUT IMPEDANCE
 $|I_{OH}| = I_{OL} = 4\text{ mA (MIN.)}$
- BALANCED PROPAGATION DELAYS
 $t_{PLH} = t_{PHL}$
- WIDE OPERATING VOLTAGE RANGE
 V_{CC} (OPR) = 2 V to 6 V
- PIN AND FUNCTION COMPATIBLE WITH
40102B/40103B



DESCRIPTION

The M54/74HC40102/40103 are high speed CMOS 8-STAGE PRESETTABLE SYNCHRONOUS DOWN COUNTERS fabricated with silicon gate C²MOS technology. They achieve the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

The HC40102, and HC40103 consist of an 8-stage synchronous down counter with a single output which is active when the internal count is zero. The HC40102 is configured as two cascaded 4-bit BCD counters, and the HC40103 contains a single 8-bit binary counter. Each type has control inputs for enabling or disabling the clock, for clearing the counter to its maximum count, and for presetting the counter either synchronously or asynchronously. All control inputs and the CARRY-OUT/ZERO-DETECT output are active-low logic. In normal operation, the counter is decremented by one count on each positive transition of the CLOCK. Counting is inhibited when the CARRY-IN/COUNTER ENABLE (CI/CE) input is high. The CARRY-OUT/ZERO-DETECT (CO/ZD) output goes low when the count reaches zero if the CI/CE input is low, and remains low for one full clock period. When the SYNCHRONOUS PRESET-ENABLE (SPE) input is low, data at the J input is clocked into the counter on the next positive clock transition regardless of the state of the CI/CE input.



M54/M74HC40102/40103

DESCRIPTION (Continued)

When the ASYNCHRONOUS PRESET-ENABLE (APE) input is low, data at the J inputs is asynchronously forced into the counter regardless of the state of the SPE, CI/CE, or CLOCK inputs. J Inputs J0-J7 represent two 4-bit BCD words for the HC40102 and a single 8-bit binary word for the HC40103. When the CLEAR (CLR) input is low, the counter is asynchronously cleared to its maximum count (99₁₀ for the HC40102 and 255₁₀ for the HC40103 regardless of the state of any other input. The precedence

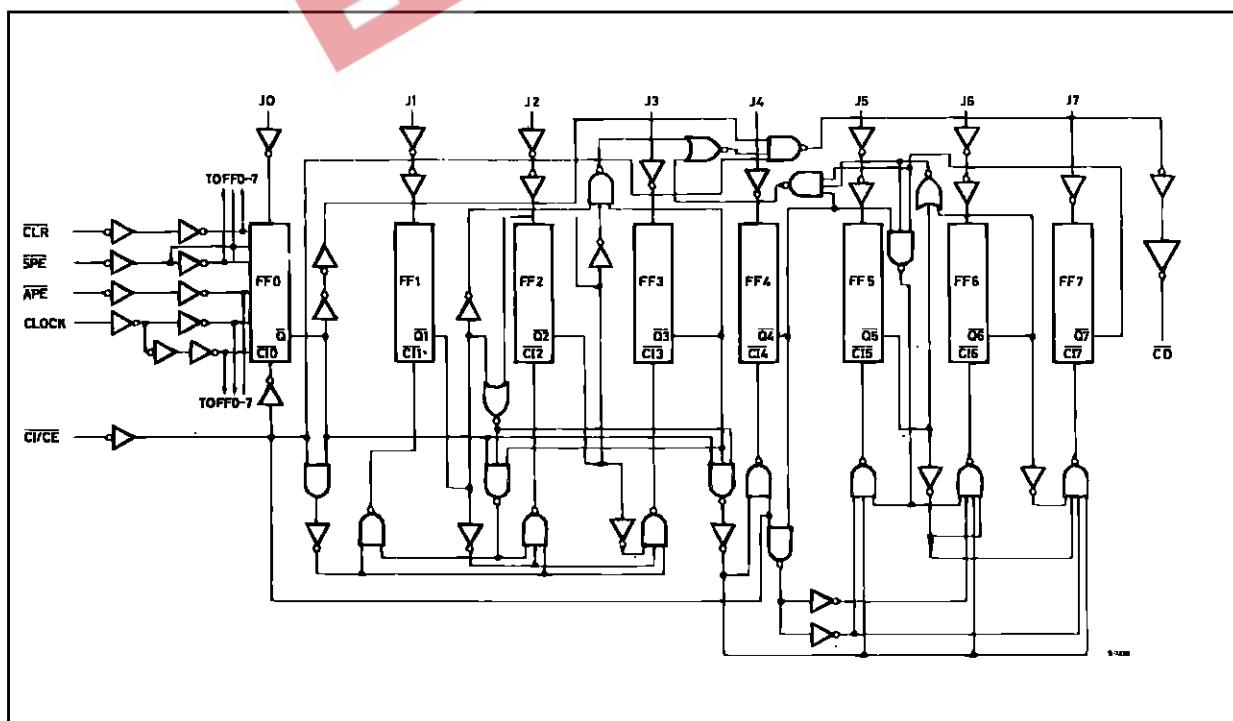
relationship between control input is indicated in the truth table. If all control inputs are high at the time of zero count, the counters will jump to the maximum count, giving a counting sequence of 100 pr 256 clock pulses long. The HC40102 and HC40103 may be cascaded using the CI/CE input and the CO/ZD output, in either a synchronous or ripple mode. All inputs are equipped with protection circuits against static discharge and transient excess voltage.

TRUTH TABLE

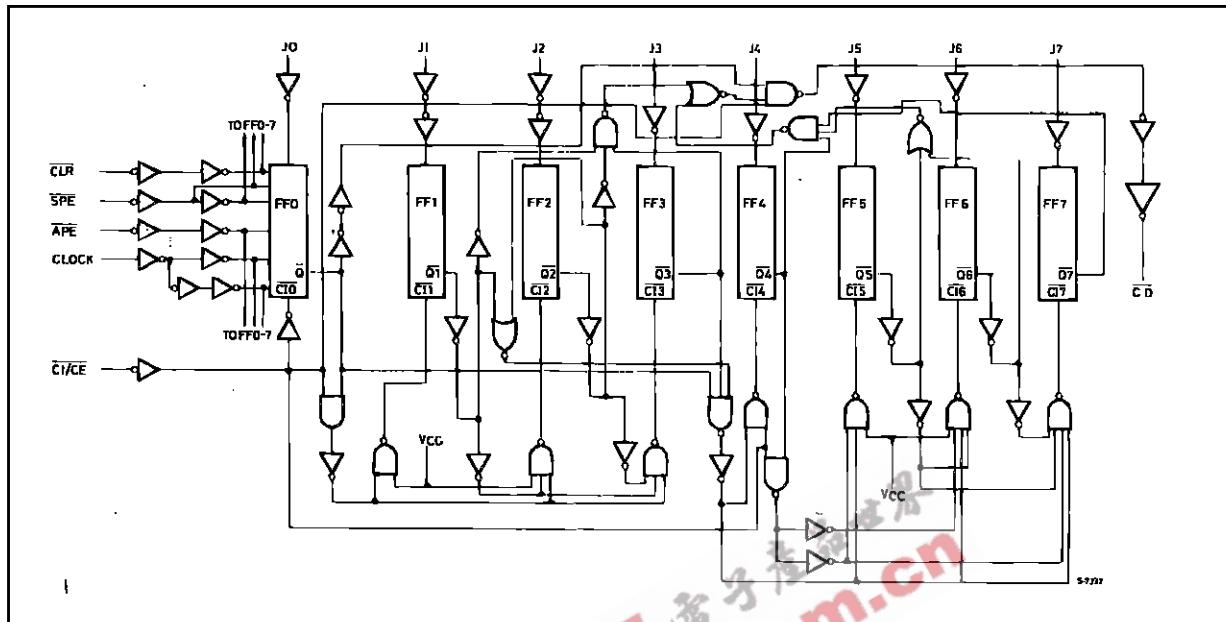
CONTROL INPUTS				MODE	FUNCTIONAL DESCRIPTION
CLEAR	APE	SPE	CI/CE		
H	H	H	H	COUNT INHIBIT	EVEN IF CLOCK IS GIVEN, NO COUNT IS MADE
H	H	H	L	REGULAR COUNT	DOWN COUNT AT RISING EDGE OF CLOCK
H	H	L	X	SYNCHRONOUS PRESET	DATA OF PI TERMINAL IS PRESET AT RISING EDGE OF CLOCK
H	L	X	X	ASYNCRONOUS PRESET	DATA OF PI TERMINAL IS ASYNCRONOUSLY PRESET TO CLOCK
L	X	X	X	CLEAR	COUNTER IS SET TO MAXIMUM COUNT

X: DON'T CARE - MAXIMUM COUNT: "99" FOR HC40102 AND "255": FOR HC40103

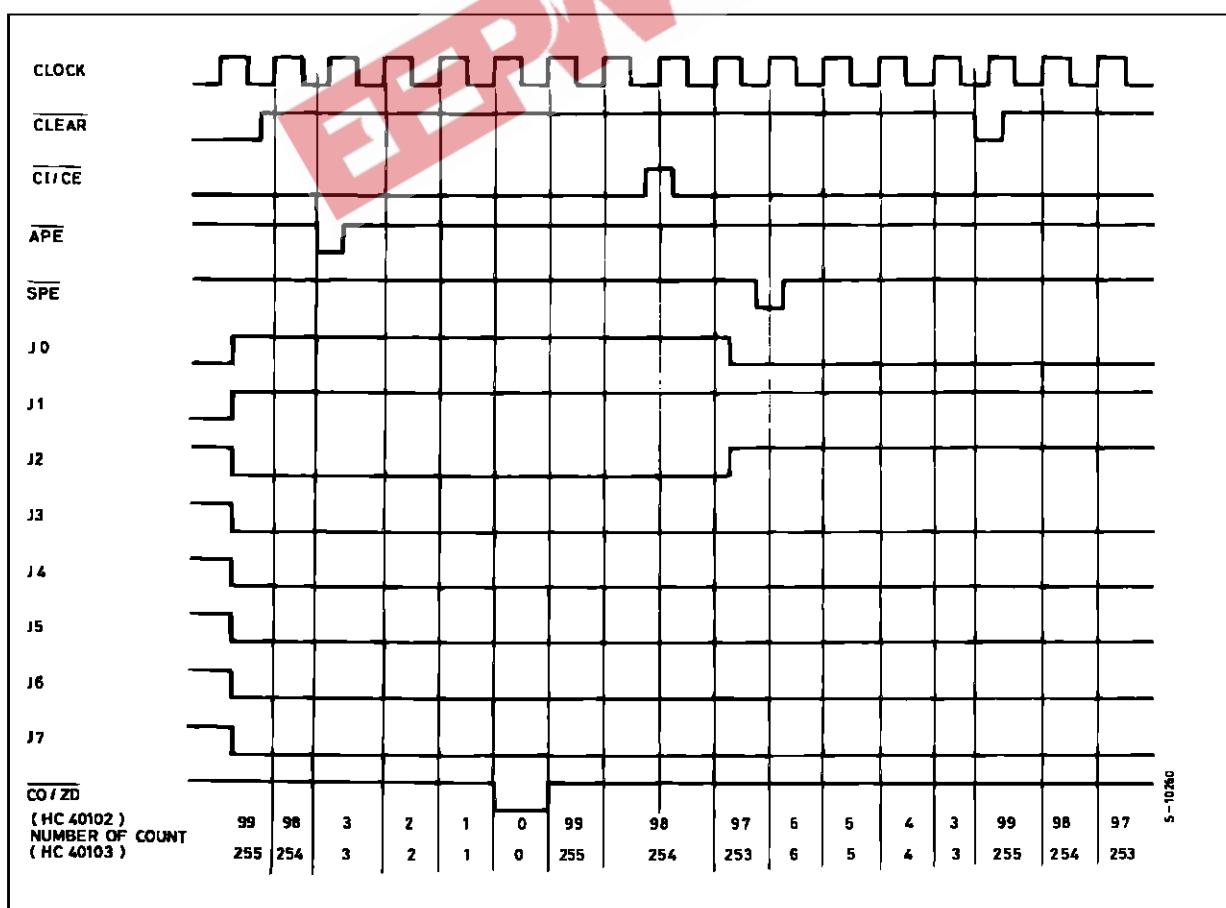
LOGIC DIAGRAM (HC40102)



LOGIC DIAGRAM (HC40103)



TIMING CHART

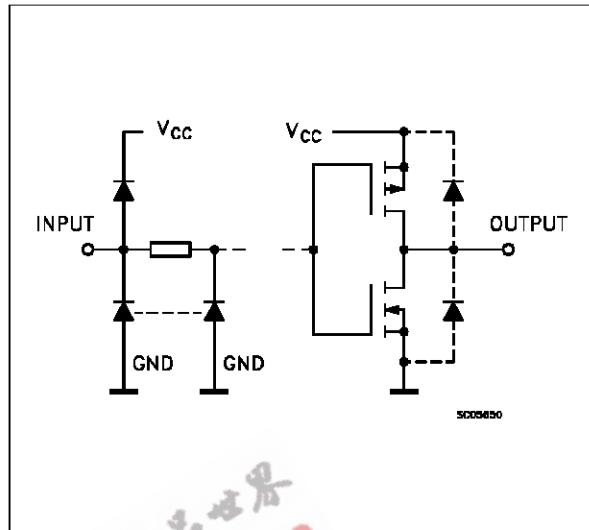


M54/M74HC40102/40103

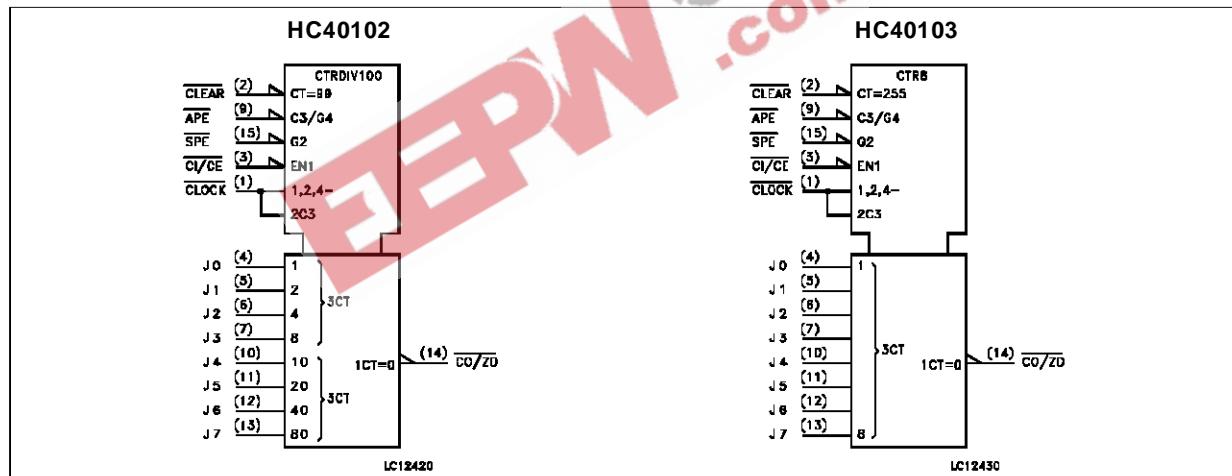
PIN DESCRIPTION

PIN No	SYMBOL	NAME AND FUNCTION
1	CLOCK	Clock Input (LOW to HIGH edge triggered)
2	CLEAR	Asynchronous Master Reset Input (Active LOW)
3	CI/CE	Terminal Enable Input
4, 5, 6, 7, 10, 11, 12, 13	J0 to J9	Jam Inputs
9	APE	Asynchronous Preset Enable Input (Active LOW)
14	CO/ZD	Terminal Count Output (Active LOW)
15	SPE	Synchronous Preset Enable Input (Active LOW)
8	GND	Ground (0V)
16	Vcc	Positive Supply Voltage

INPUT AND OUTPUT EQUIVALENT CIRCUIT



IEC LOGIC SYMBOLS



ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V _{CC}	Supply Voltage	-0.5 to +7	V
V _I	DC Input Voltage	-0.5 to V _{CC} + 0.5	V
V _O	DC Output Voltage	-0.5 to V _{CC} + 0.5	V
I _{IK}	DC Input Diode Current	± 20	mA
I _{OK}	DC Output Diode Current	± 20	mA
I _O	DC Output Source Sink Current Per Output Pin	± 25	mA
I _{CC} or I _{GND}	DC V _{CC} or Ground Current	± 50	mA
P _D	Power Dissipation	500 (*)	mW
T _{stg}	Storage Temperature	-65 to +150	°C
T _L	Lead Temperature (10 sec)	300	°C

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these condition is not implied.

(*) 500 mW: $\leq 65^{\circ}\text{C}$ derate to 300 mW by 10mW/°C: 65°C to 85°C

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Value			Unit
V _{CC}	Supply Voltage	2 to 6			V
V _I	Input Voltage	0 to V _{CC}			V
V _O	Output Voltage	0 to V _{CC}			V
T _{op}	Operating Temperature: M54HC Series M74HC Series	-55 to +125 -40 to +85			°C °C
t _r , t _f	Input Rise and Fall Time	V _{CC} = 2 V	0 to 1000		
		V _{CC} = 4.5 V	0 to 500		
		V _{CC} = 6 V	0 to 400		

DC SPECIFICATIONS

Symbol	Parameter	Test Conditions		Value						Unit	
		V _{CC} (V)		T _A = 25 °C 54HC and 74HC			-40 to 85 °C 74HC		-55 to 125 °C 54HC		
				Min.	Typ.	Max.	Min.	Max.	Min.	Max.	
V _{IH}	High Level Input Voltage	2.0		1.5			1.5		1.5		V
		4.5		3.15			3.15		3.15		
		6.0		4.2			4.2		4.2		
V _{IL}	Low Level Input Voltage	2.0			0.5		0.5		0.5		V
		4.5			1.35		1.35		1.35		
		6.0			1.8		1.8		1.8		
V _{OH}	High Level Output Voltage	2.0	V _I = V _{IH} or V _{IL} I _O =-20 μA	1.9	2.0		1.9		1.9		V
		4.5		4.4	4.5		4.4		4.4		
		6.0		5.9	6.0		5.9		5.9		
		4.5		I _O =-4.0 mA	4.18	4.31		4.13		4.10	
		6.0		I _O =-5.2 mA	5.68	5.8		5.63		5.60	
V _{OL}	Low Level Output Voltage	2.0	V _I = V _{IH} or V _{IL} I _O = 20 μA		0.0	0.1		0.1		0.1	V
		4.5			0.0	0.1		0.1		0.1	
		6.0			0.0	0.1		0.1		0.1	
		4.5		I _O = 4.0 mA		0.17	0.26		0.33		0.40
		6.0		I _O = 5.2 mA		0.18	0.26		0.33		0.40
I _I	Input Leakage Current	6.0	V _I = V _{CC} or GND			±0.1		±1		±1	μA
I _{CC}	Quiescent Supply Current	6.0	V _I = V _{CC} or GND			4		40		80	μA

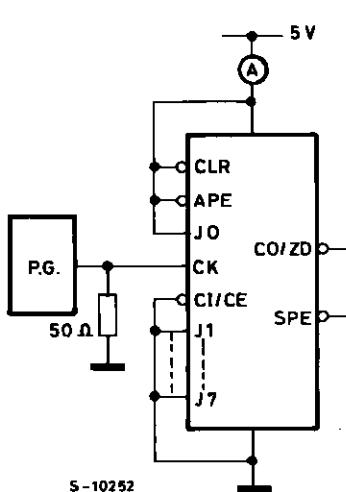
M54/M74HC40102/40103

AC ELECTRICAL CHARACTERISTICS ($C_L = 50 \text{ pF}$, Input $t_r = t_f = 6 \text{ ns}$)

Symbol	Parameter	Test Conditions		Value						Unit	
		V _{CC} (V)		T _A = 25 °C 54HC and 74HC			-40 to 85 °C 74HC		-55 to 125 °C 54HC		
				Min.	Typ.	Max.	Min.	Max.	Min.	Max.	
t _{TTLH} t _{THL}	Output Transition Time	2.0			30	75		95		110	ns
		4.5			8	15		19		22	
		6.0			7	13		16		19	
t _{TPLH} t _{PHL}	Propagation Delay Time (CK - CO/ZD)	2.0			96	185		230		280	ns
		4.5			24	37		46		56	
		6.0			20	31		39		47	
t _{TPLH} t _{PHL}	Propagation Delay Time (APE - CO/ZD)	2.0			116	225		280		340	ns
		4.5			29	45		56		68	
		6.0			25	38		48		57	
t _{TPLH} t _{PHL}	Propagation Delay Time (CL - CO/ZD)	2.0			104	200		250		300	ns
		4.5			26	40		50		60	
		6.0			22	34		43		51	
t _{TPLH} t _{PHL}	Propagation Delay Time (CI/CE - CO/ZD)	2.0			48	95		120		145	ns
		4.5			12	19		24		29	
		6.0			10	16		20		24	
f _{MAX}	Propagation Delay Time	2.0		4	8		3		2.6		pF
		4.5		20	32		16		13		
		6.0		24	38		19		15		
C _{IN}	Input Capacitance				5	10		10		10	pF
C _{PD} (*)	Power Dissipation Capacitance				60						pF

(*) C_{PD} is defined as the value of the IC's internal equivalent capacitance which is calculated from the operating current consumption without load. (Refer to Test Circuit). Average operating current can be obtained by the following equation. I_{CC(Opr)} = C_{PD} • V_{CC} • f_{IN} + I_{CC}

TEST CIRCUIT I_{CC} (Opr.)



INPUT TRANSITION TIME IS THE SAME AS THAT IN CASE OF SWITCHING CHARACTERISTICS TEST.

FUNCTIONAL DESCRIPTION

The HC40102 and HC40103 are 8-stage presettable synchronous down counters. Carry Out/Zero Detect ($\overline{CO/ZD}$) is output at the "L" level for the period of 1 bit when the readout becomes "0". The HC40102 adopts binary coded decimal notation, making setting up to 99 counts possible. While the HC40103 adopts 8-bit binary counter and can set up to 255 counts.

COUNT OPERATION

At the "H" level of control input of CLEAR, SPE and APE, the counter carries out down count operation one by one at the rise of pulse given to CLOCK input. Count operation can be inhibited by setting Carry Input/Clock Enable CI/CE to the "H" level.

CO/ZD is output at the "L" level when the readout becomes "0" but is not output even if the readout becomes "0" when CI/CE is at the "H" level, thus maintaining the "H" level.

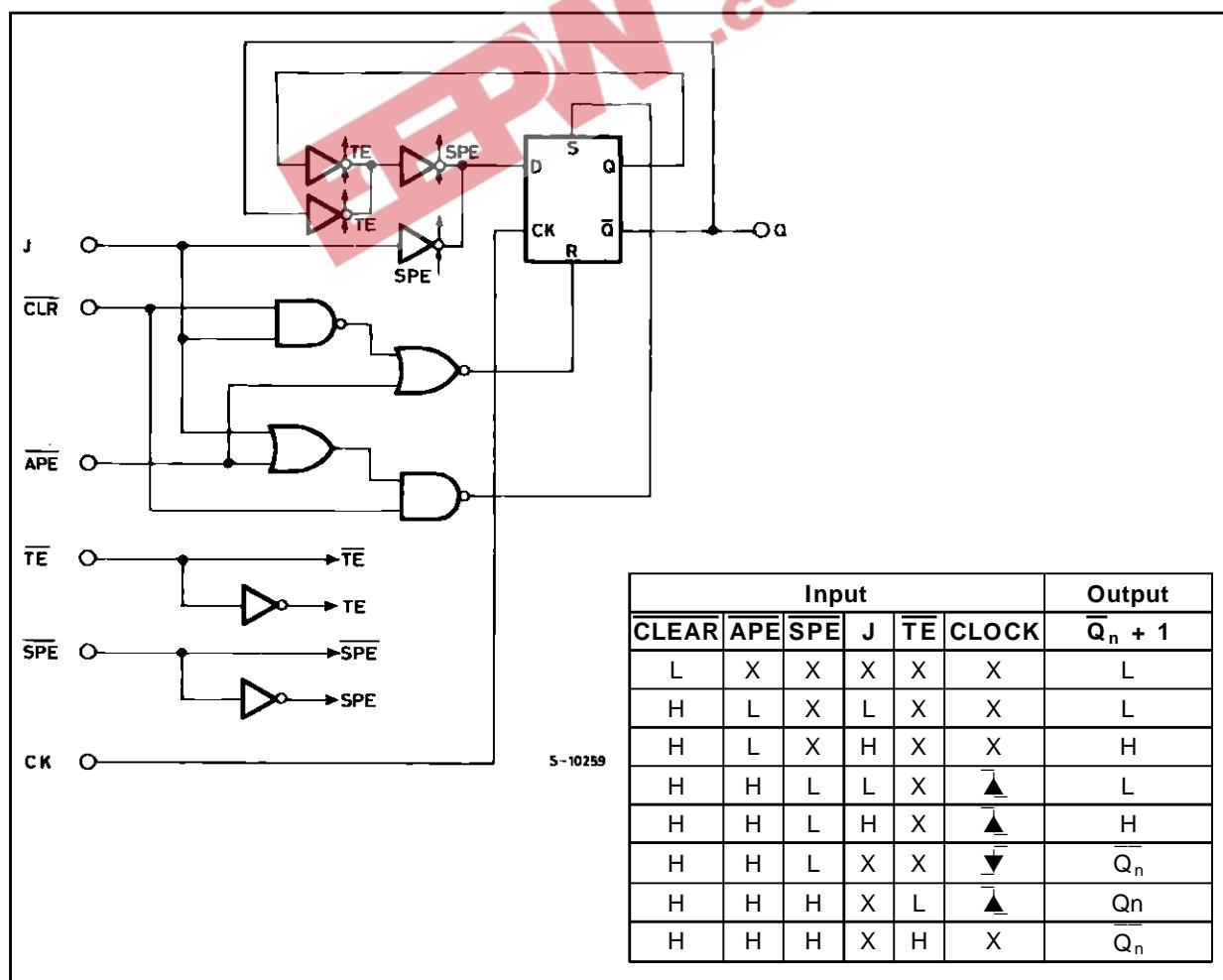
Synchronous cascade operation can be carried out by using CI/CE input and CO/ZD output.

The contents of count jump to maximum count (99 for the HC40102 and 225 for the HC40103) if clock is given when the readout is "0". Therefore, operation of 100-frequency division and that of 256-frequency division are carried out for the HC40102 and HC40103, respectively, when clock input alone is given without various kinds of preset operation.

RESET OPERATION AND RESET OPERATION

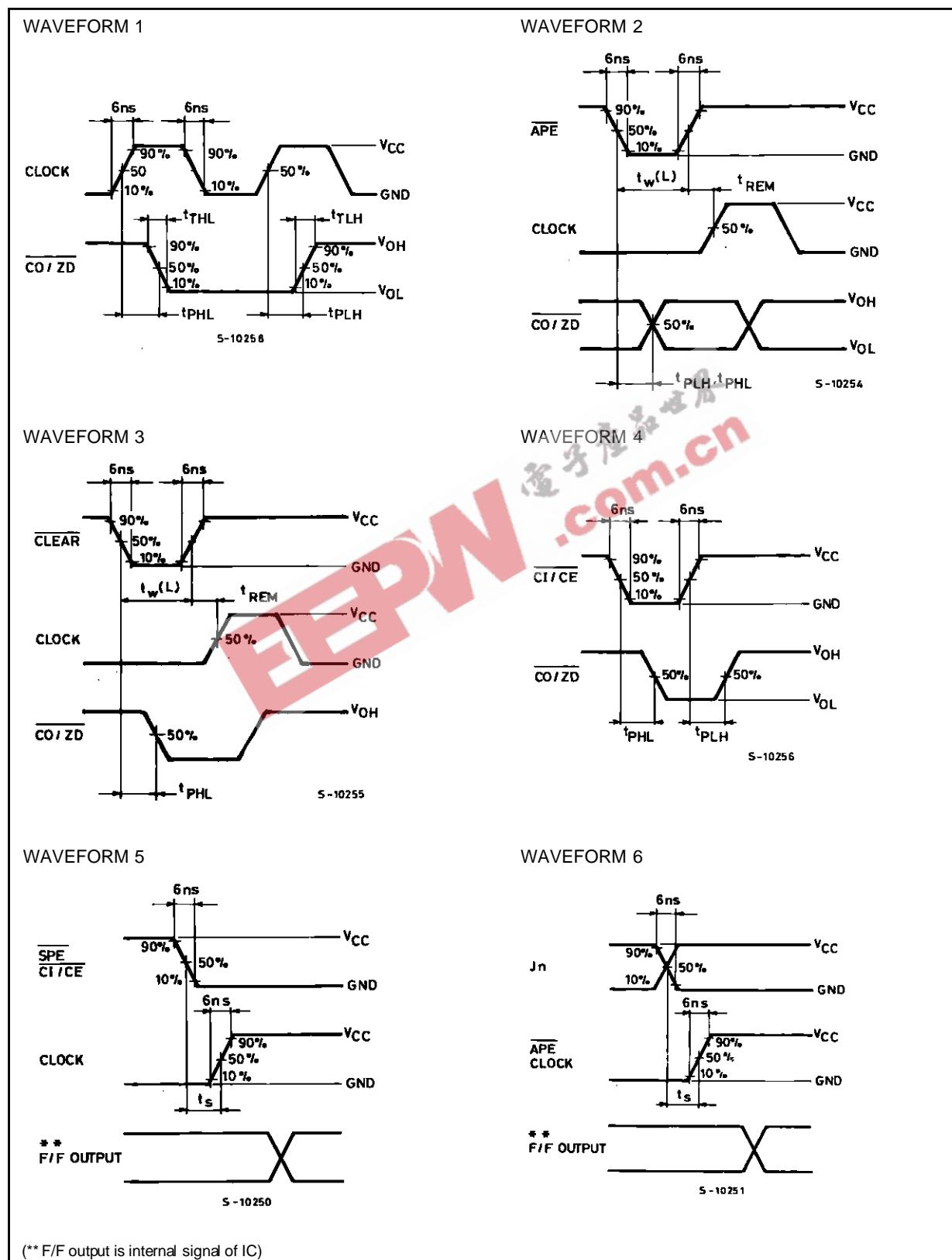
When Clear (CLEAR) input is set to the "L" level, the readout is set to the maximum count independently of other inputs. When Asynchronous Preset Enable (APE) input is set to the "L" level, readouts given on J0 to J7 can be preset asynchronously to counter independently of inputs other than CLEAR input. When Synchronous Preset Enable (SPE) is set to the "L" level, the readouts given on J0 to J7 can be preset to counter synchronously with the rise of clock.

As to these operation modes, refer to the truth table.



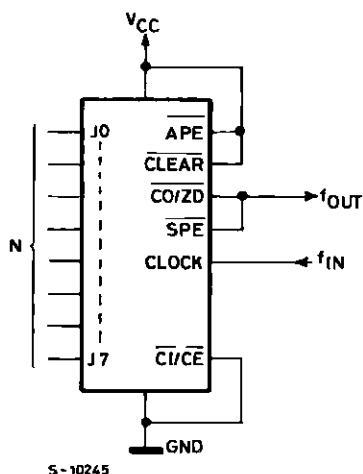
M54/M74HC40102/40103

SWITCHING CHARACTERISTICS TEST WAVEFORM

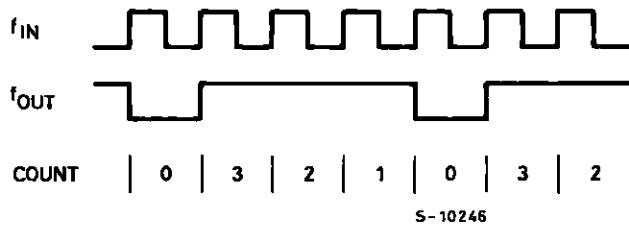


EXAMPLE OF TYPICAL APPLICATION

PROGRAMMABLE DIVIDE-BY-N COUNTER

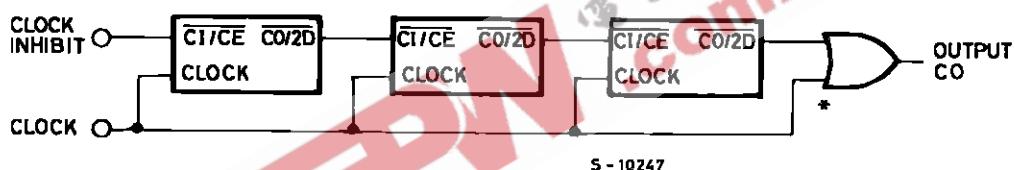


- $f_{OUT} = \frac{f_{IN}}{N+1}$
- Timing chart when N = "3"
(J0, J1 = V_{cc}, J2 – J7 = GND)



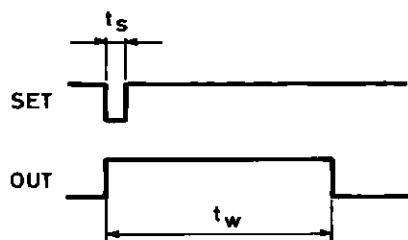
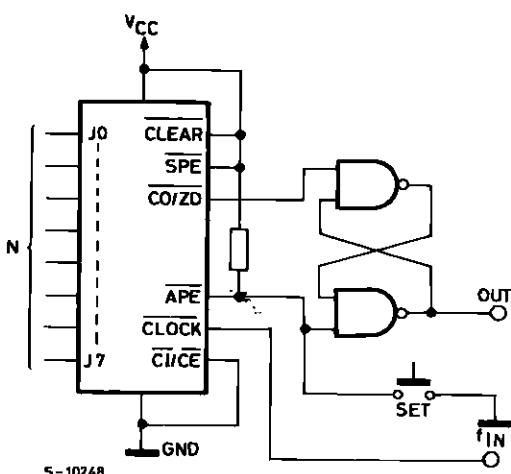
- HC40102... 1/2 to 1/100 are dividable
- HC40103... 1/2 to 1/256 are dividable

PARALLEL CARRY CASCADING



* At synchronous cascade connection, hazard occurs at C0 output after its second stage when digitplace changes, due to delay arrival. Therefore, take gate from HC32 or the like, not from C0 output at the rear stage directly.

PROGRAMMABLE TIMER

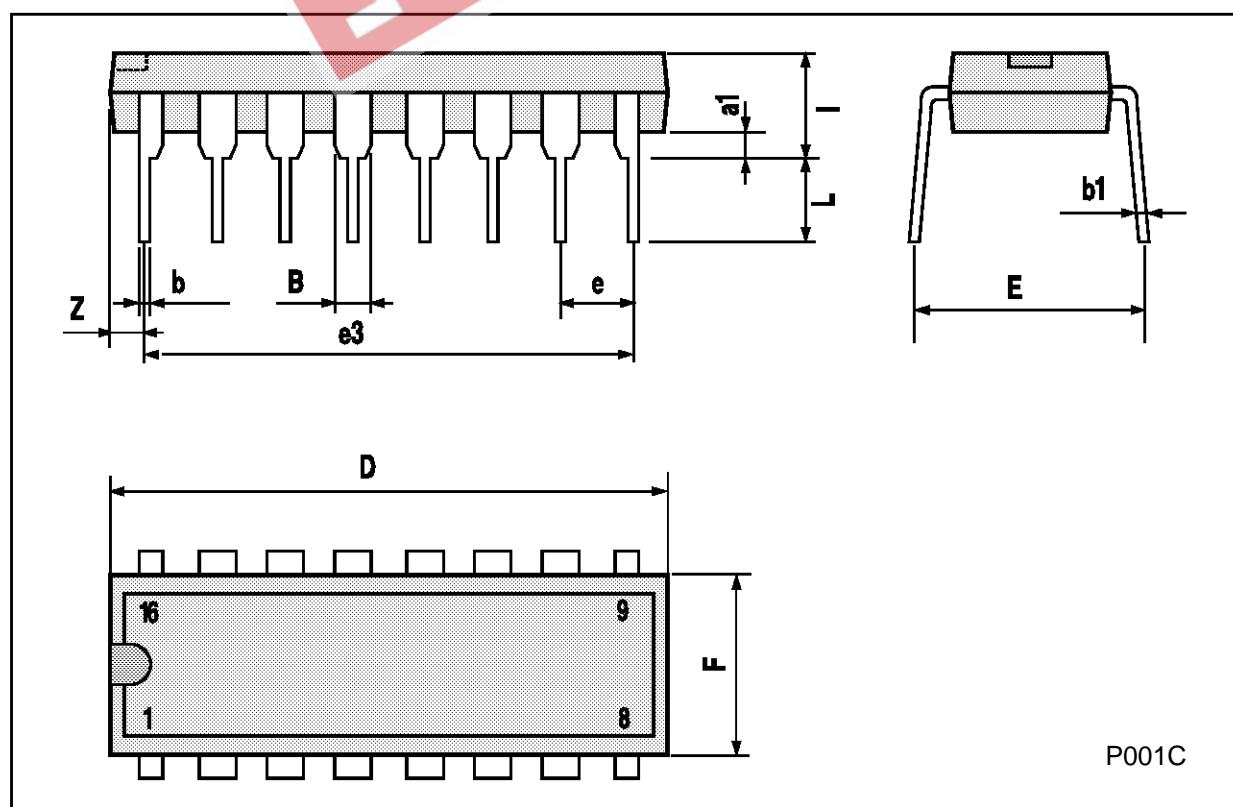


$$t_W = \left(\frac{N}{f_{IN}} + t_s \right)$$

Note :The above formula does not take into account the phase of clock input. Therefore, the real pulse width is the distance between the above formula-1/f_{IN} ~ the above formula.

Plastic DIP16 (0.25) MECHANICAL DATA

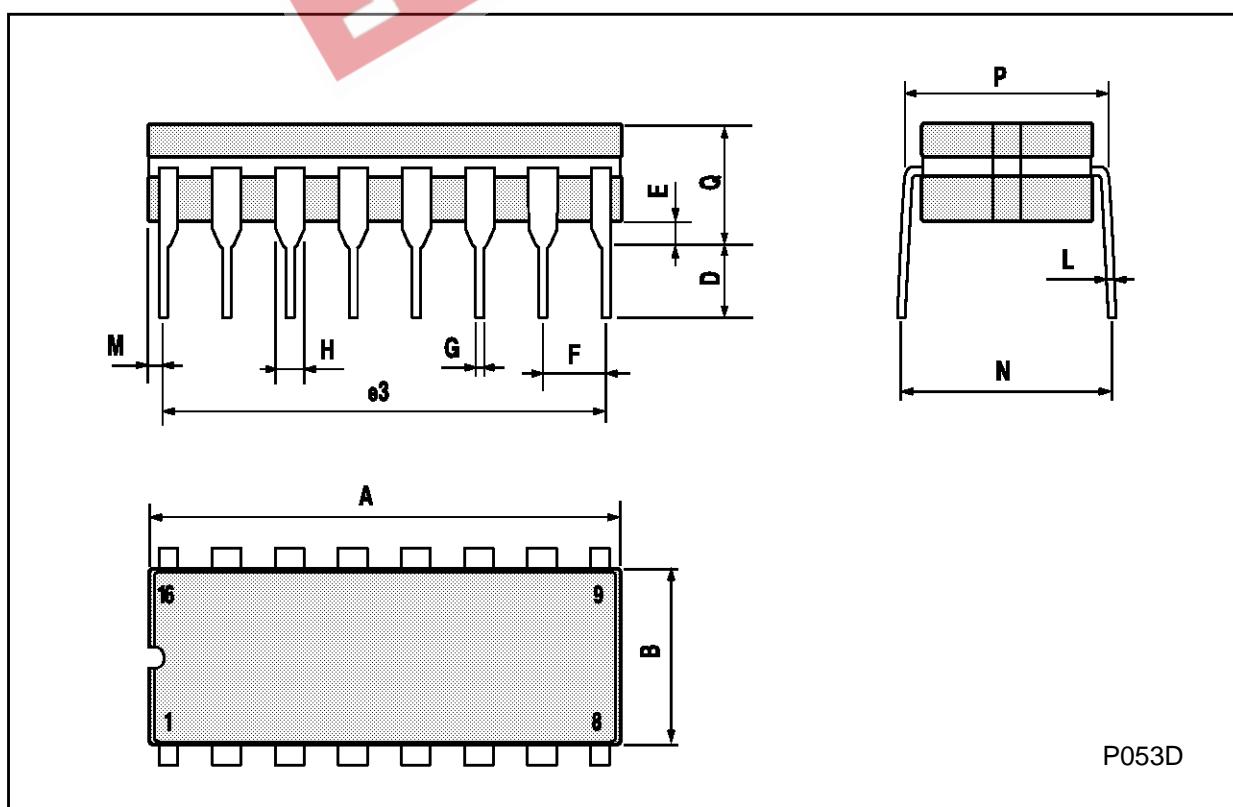
DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
a1	0.51			0.020		
B	0.77		1.65	0.030		0.065
b		0.5			0.020	
b1		0.25			0.010	
D			20			0.787
E		8.5			0.335	
e		2.54			0.100	
e3		17.78			0.700	
F			7.1			0.280
I			5.1			0.201
L		3.3			0.130	
Z			1.27			0.050



P001C

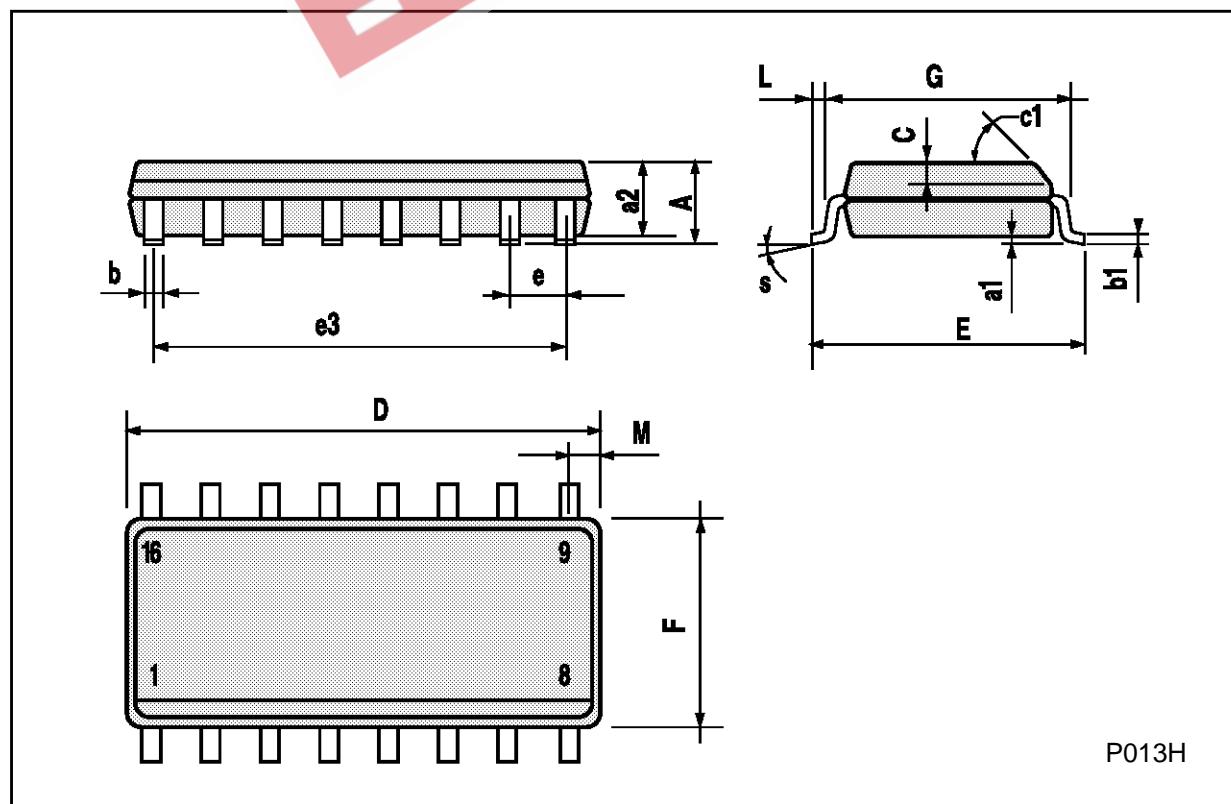
Ceramic DIP16/1 MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			20			0.787
B			7			0.276
D		3.3			0.130	
E	0.38			0.015		
e3		17.78			0.700	
F	2.29		2.79	0.090		0.110
G	0.4		0.55	0.016		0.022
H	1.17		1.52	0.046		0.060
L	0.22		0.31	0.009		0.012
M	0.51		1.27	0.020		0.050
N			10.3			0.406
P	7.8		8.05	0.307		0.317
Q			5.08			0.200



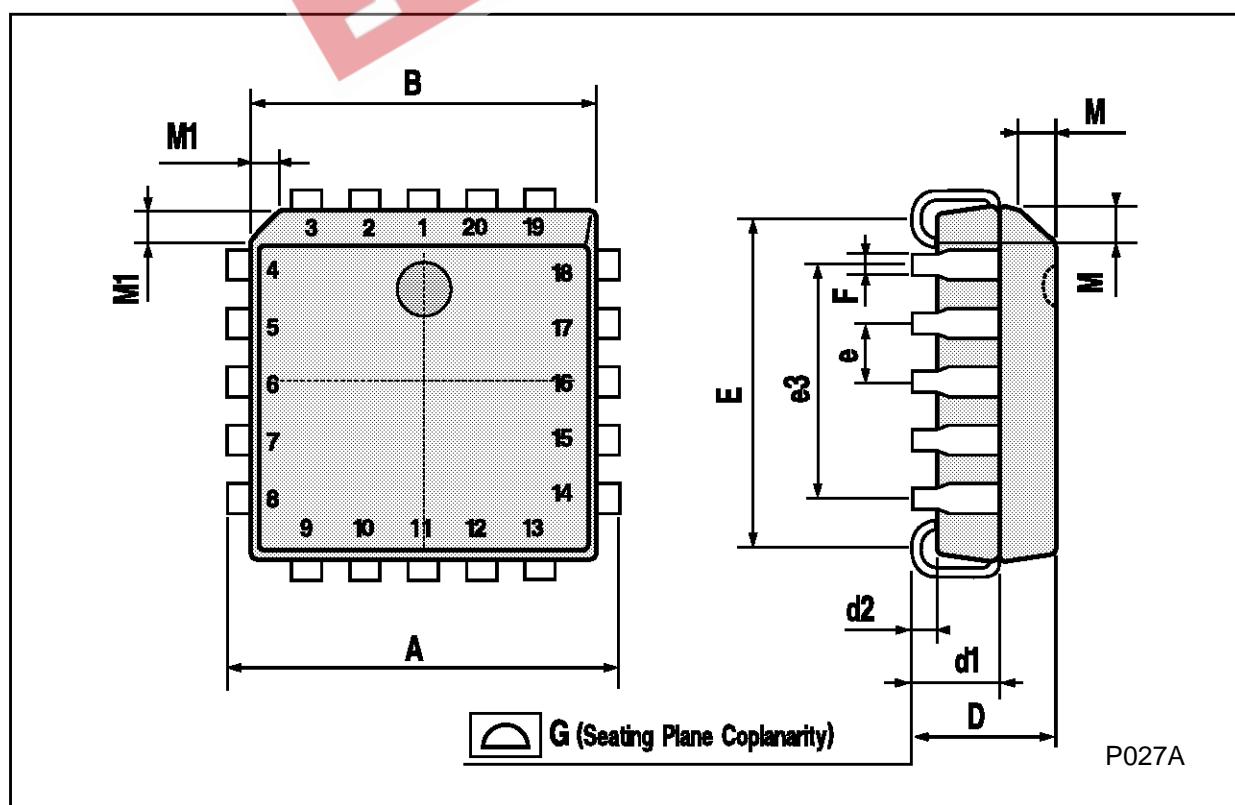
SO16 (Narrow) MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			1.75			0.068
a1	0.1		0.2	0.004		0.007
a2			1.65			0.064
b	0.35		0.46	0.013		0.018
b1	0.19		0.25	0.007		0.010
C		0.5			0.019	
c1		45° (typ.)				
D	9.8		10	0.385		0.393
E	5.8		6.2	0.228		0.244
e		1.27			0.050	
e3		8.89			0.350	
F	3.8		4.0	0.149		0.157
G	4.6		5.3	0.181		0.208
L	0.5		1.27	0.019		0.050
M			0.62			0.024
S		8° (max.)				



PLCC20 MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	9.78		10.03	0.385		0.395
B	8.89		9.04	0.350		0.356
D	4.2		4.57	0.165		0.180
d1		2.54			0.100	
d2		0.56			0.022	
E	7.37		8.38	0.290		0.330
e		1.27			0.050	
e3		5.08			0.200	
F		0.38			0.015	
G			0.101			0.004
M		1.27			0.050	
M1		1.14			0.045	



M54/M74HC40102/40103

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